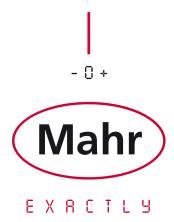
MarSurf



MarSurf WM 100 *

3D Measurement System - White Light Interferometer



- High precision with sub nanometer resolution
- Ideal for optical, reflecting and technical surfaces
- 2D surface analysis and measurement evaluation
- Topographic 3D surface analysis and measurement evaluation
- Fast measurement short measuring time

^{*} Instrument shown with optional Active Vibration Damping Table





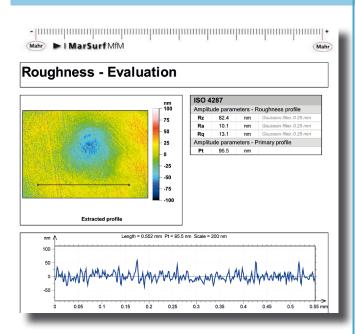
MarSurf WM 100

Description

Surface scanning sensor ideally suited for fast-paced measurement of smallest to medium sized surface details, like roughness measurement in sub-nanometers. Excellent, high resolution reproduction of even microscopic surface details.

- Microscopic technology dedicated to the reproduction of tiny surface features up to the physical limit
- surface features up to the physical limit
 Combined phase measuring and vertical scanning technology
- with high performance objectives gives fast, precise and reliable results
- Robust, maintenance free, built for long service life
- Complete assortment of premium quality objectives available
- 120 mm xy table allows precise movement of measuring object. Additional angular tilt table available
- Optional CNC controlled measuring table for stiching process available

Evaluation



Measuring Report: Roughness Measurement

- Optional powerful evaluation software **MarSurf MfM** and **MarSurf MfM plus**
- Measurement of topography, height, shape and position of surface structures as well as standardized 3D surface parameters and 2D roughness parameters



MarSurf WM 100 - Technical Data

	Standard Optics	Optional Optics
Light source	High performance LED, $\lambda = 505$ nm	High performance LED, $\lambda = 505 \text{ nm}$
Measuring range	100 μm	250 μm or 400 μm
Lense	20x	2.5x - 5x - 10x - 50x - 100x
Numerical aperture	0.4	from 0.075 to 0.7
Working distance	4.7 mm	from 10.3 to 2.0 mm
Field of view	890 μm x 655 μm	7120 μm x 5340 μm - 178 μm x 134 μm
Resolution (X; Y)	1.16 µm	from 9.24 µm to 0.23 µm (geometrical)
Resolution (Z)	0.1 nm	1.0 nm (2.5 - 10x); 0.1 nm (20 - 100x)

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